

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,452	JIANG ET AL.	
Examiner	Art Unit	
James D. Ewart	2683	

SEARCHED					
Class	Subclass	Date	Examiner		
455	67.11	11/9/2005	JDE		
	115.1				
	418				
	419				
	450				
	452				
	453				
	455				
	509				
	561				
370	431				
	439				
	443				
	464				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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